

Electronic Supplementary Information

Effect of Boron Doping on Electrical Conductivity of Metallicity–Separated Single Walled Carbon Nanotube

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- Table of measured resistivity at room temperature (297 K).

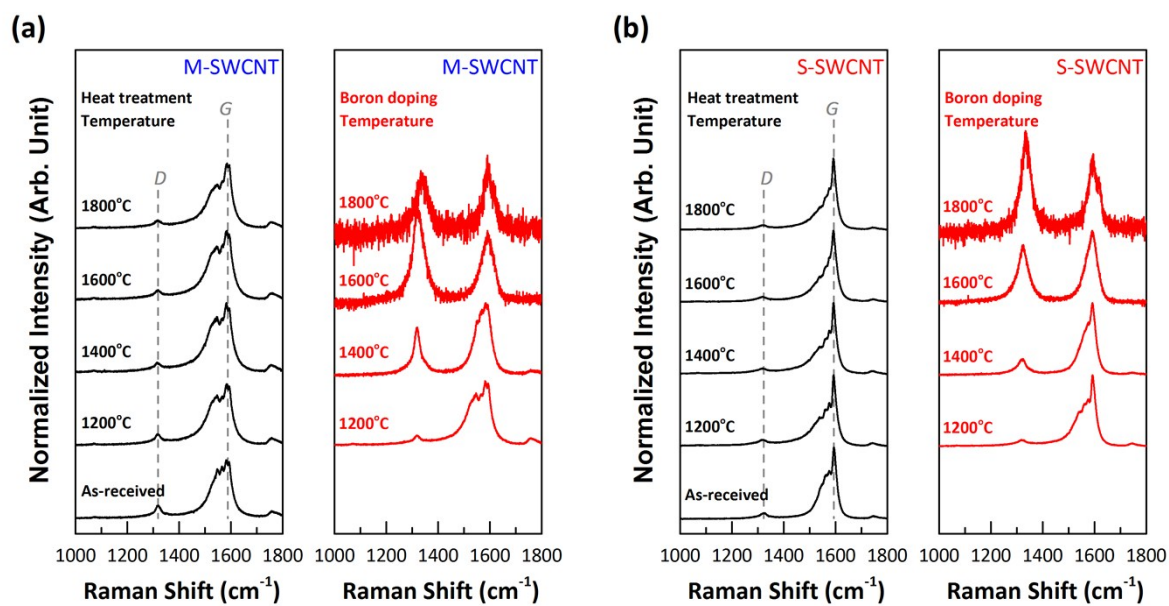


Figure S1. Raman spectra plotted with relative Raman intensity acquired from the metallic (a) and semiconducting (b) SWCNTs before and after heat-treatment, and boron doping.

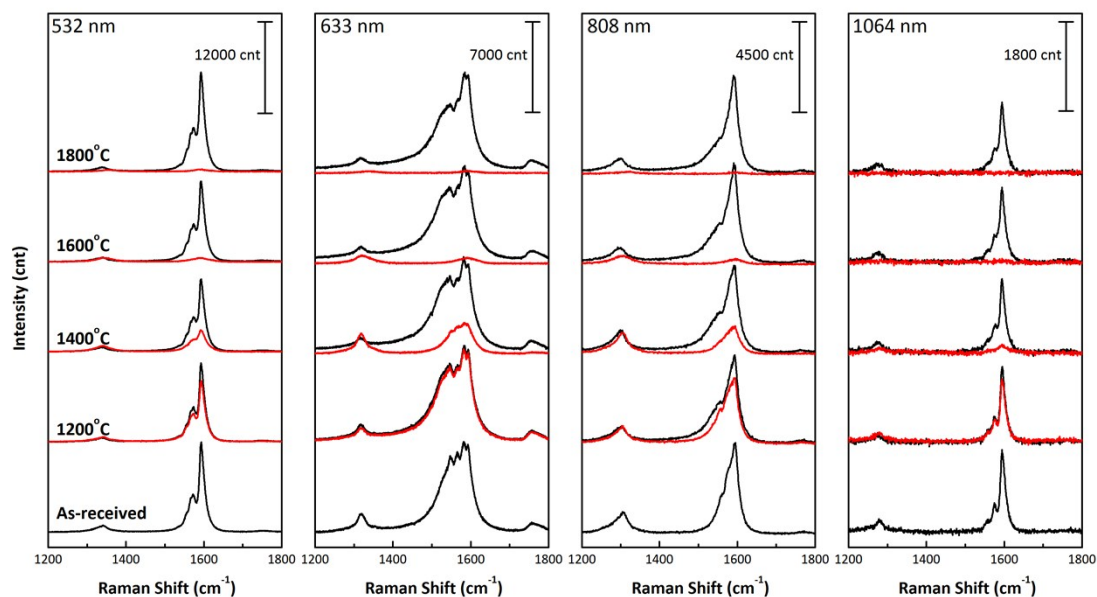


Figure S2. First order Raman spectra showing the D and G bands for the as-received, heat-treated (black line) and boron doped (red line) M-SWCNTs, taken with four different laser lines.

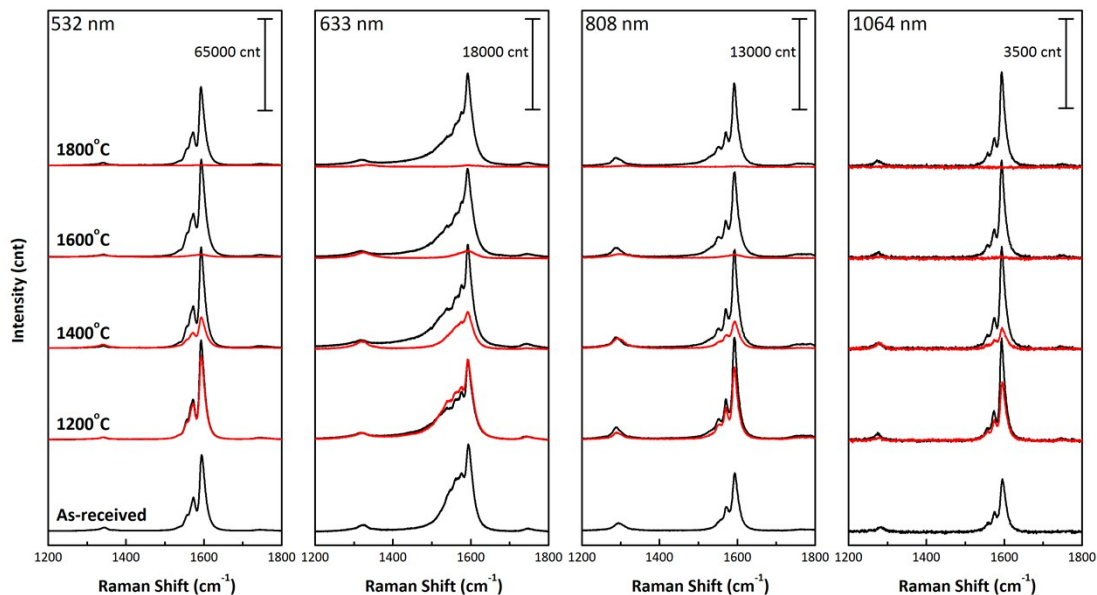


Figure S3. First order Raman spectra showing the D and G bands for the as-received, heat-treated (black line) and boron doped (red line) S-SWCNTs, taken with four different laser lines.

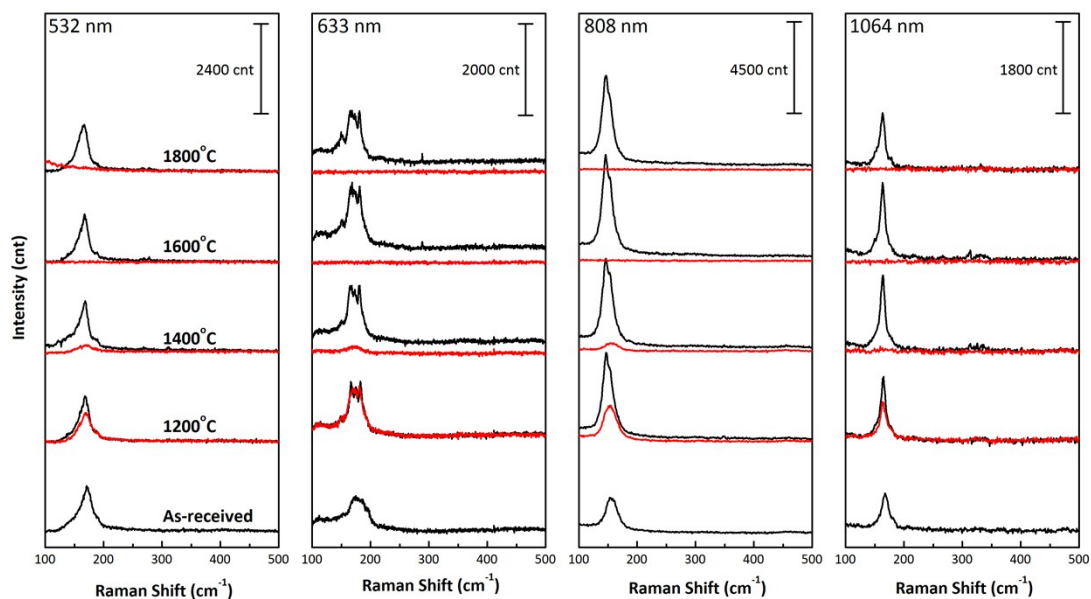


Figure S4. Low-frequency Raman spectra for the as-received, heat-treated (black line) and boron doped (red line) M-SWCNTs, taken with four different laser lines.

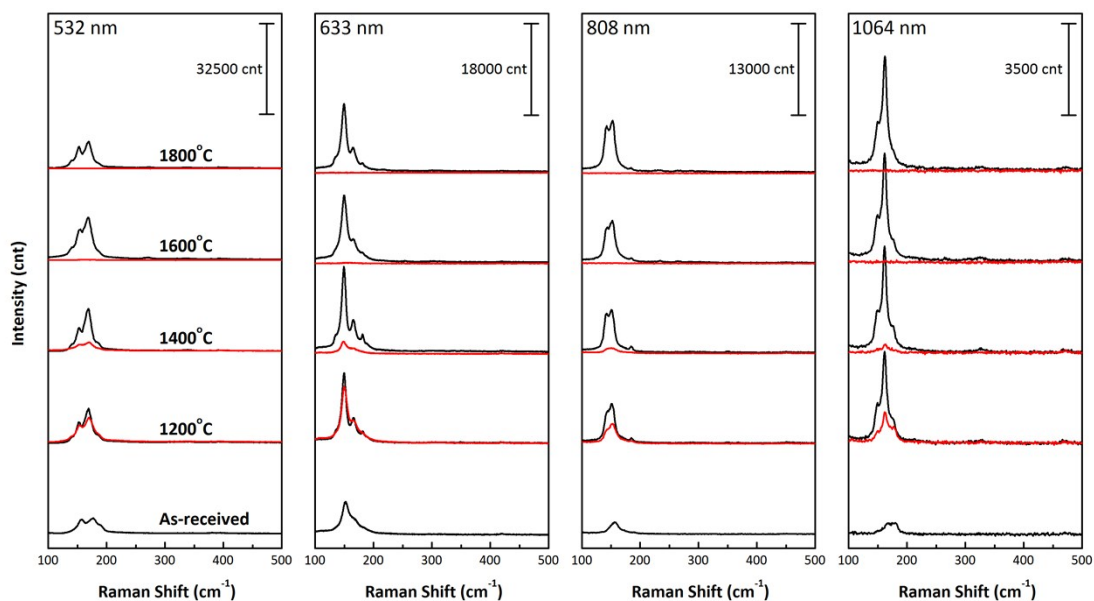


Figure S5. Low-frequency Raman spectra for the as-received, heat-treated (black line) and boron doped (red line) S-SWCNTs, taken with four different laser lines.

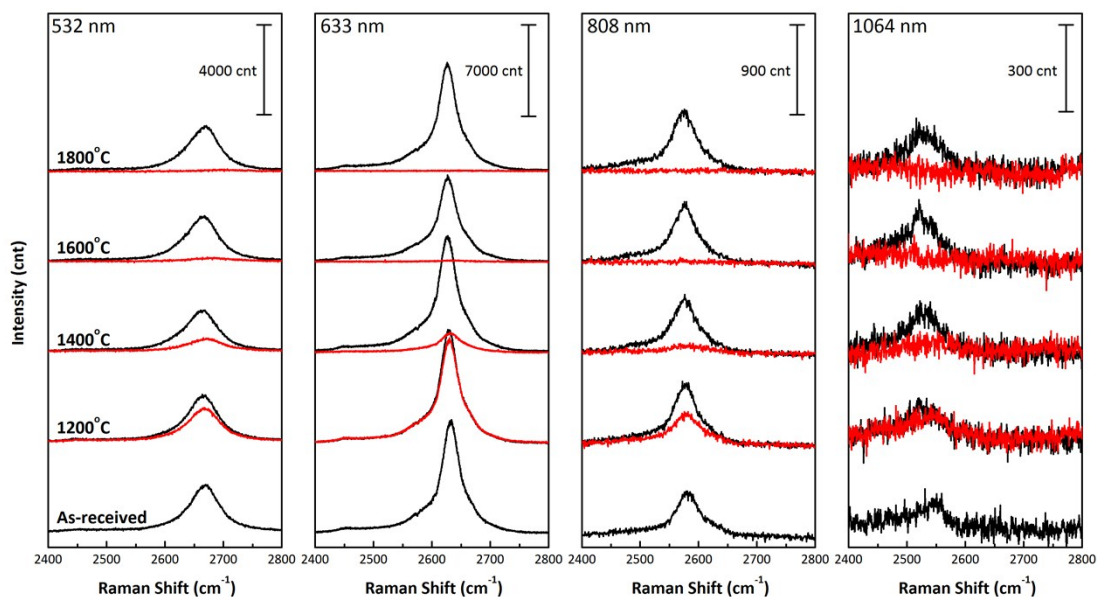


Figure S6. Second order Raman spectra for the as-received, heat-treated (black line) and boron doped (red line) M-SWCNTs, taken with four different laser lines.

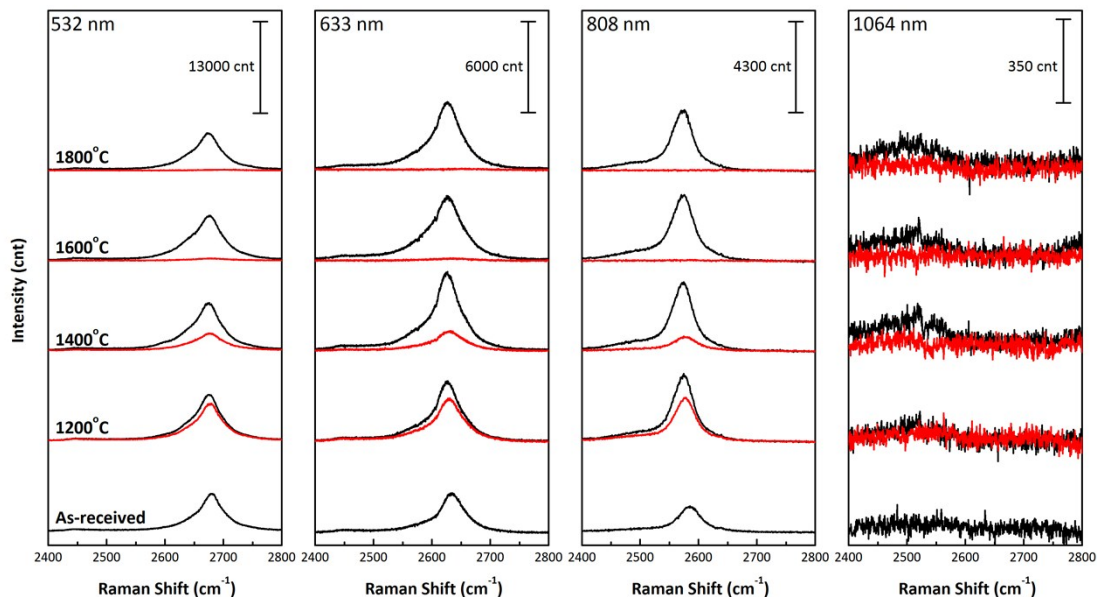


Figure S7. Second order Raman spectra for the as-received, heat-treated (black line) and boron doped (red line) S-SWCNTs, taken with four different laser lines.

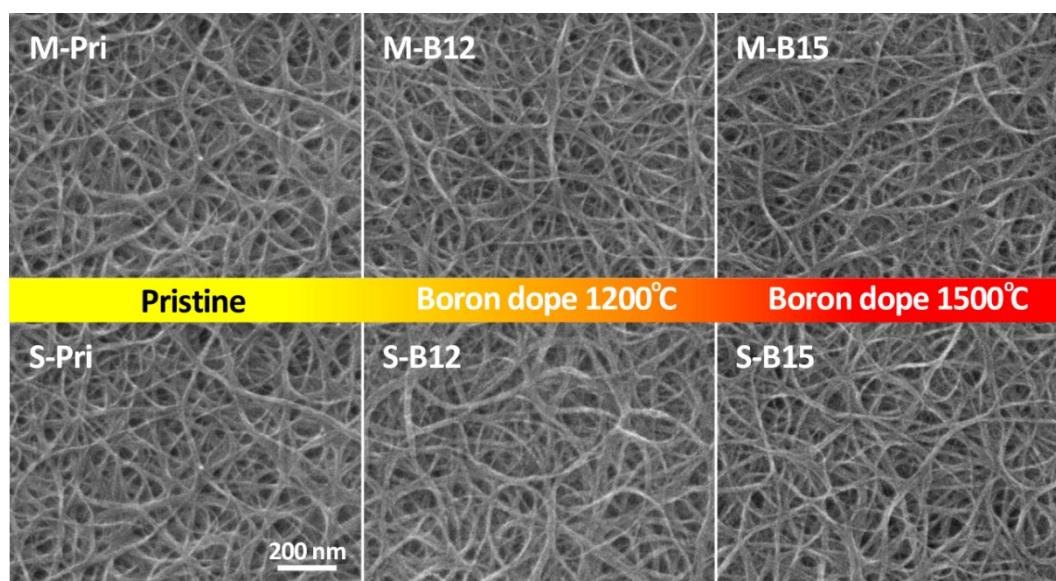


Figure S8. Scanning electron microscopic images of the pristine and boron doped M-SWCNTs and S-SWCNTs. There is no distinctive change in the surface morphology before and after boron doping.

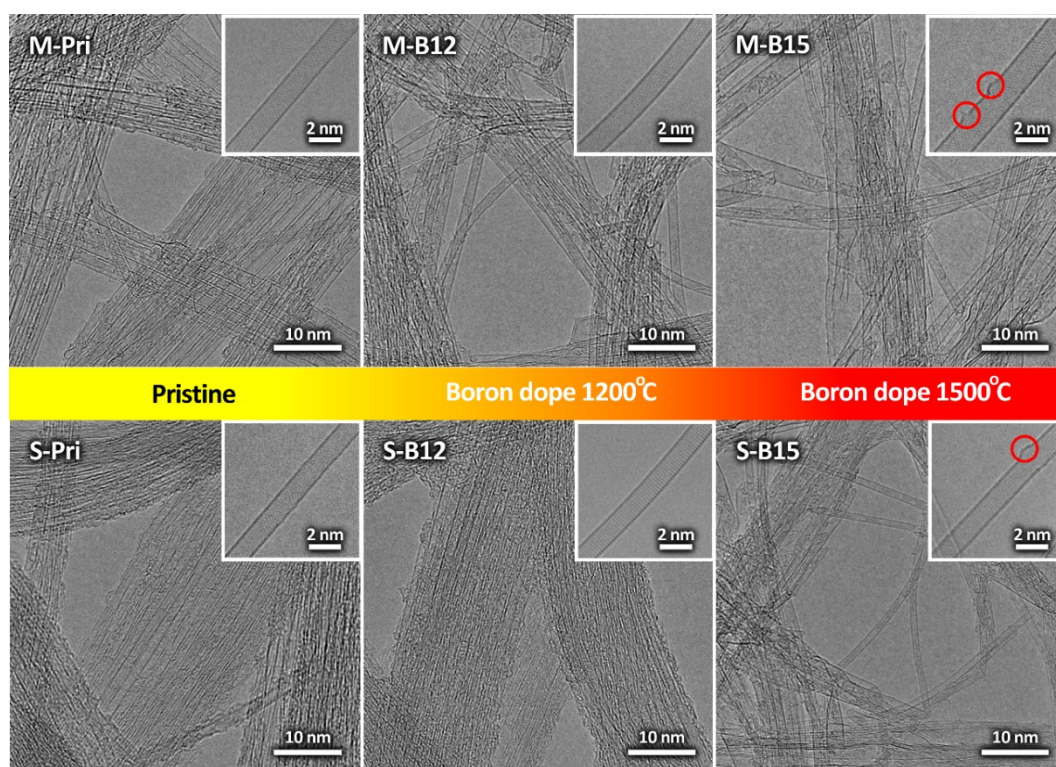


Figure S9. Aberration corrected high resolution transmission electron microscopic images of the pristine and boron doped M-SWCNTs and S-SWCNTs. The red circles in the inset for SWCNTs doped at 1500°C indicate structural defect possibly caused by the incorporation of boron atoms and the formation of BC_3 domain.

Table S1 Chemical state of boron atom in boron doped carbon system.

Material	Precursor	Peak Position	Assignment	Reference
B-pyrocarbon [1]	Boron Chloride (BCl ₃)	186.5	B Cluster	
		187.8	B ₄ C	
		188.8	BC ₃	
		190.0	BC ₂ O	
		192.0	BCO ₂	
		193.2	B ₂ O ₃	
B-DWCNT [2]	Borane (BH ₃)	191.4	BC ₃	
B-SWCNT [3]	Triisopropyl Borate (C ₉ H ₂₁ BO ₃)	187.0	Elemental Boron	Referring [2]
		190.0	BC ₃ in Carbon	
		191.5-192.1	BC ₃ in SWCNT	
		198.0	-	
		199.5	-	
B-Graphene [4]	Diborane (B ₂ H ₆), Boron-stuffed Graphite	189.0	BC ₃	Referring [2]
B-Graphene [5]	Boron Oxide (B ₂ O ₃)	187.7	B ₄ C	Referring [2], [3]
		189.0	BC ₃	
		190.4	BC ₂ O	
		191.9	BCO ₂	
B-Graphene [6]	Boric Acid (H ₃ BO ₃)	186.7	B ₄ C	Referring [4]
		187.1	Elemental Boron	
		190.6	BC ₃	
B-Graphene [7]	Trimethylboron (B(CH ₃) ₃)	189.7	B-C	Referring [2], [3]
B-Graphene [8]	Phenylboronic Acid (C ₆ H ₇ BO ₂)	190.9	BC ₃	Referring [2]
B-Graphene/ Ni(111) [9]	Triethylborane (C ₆ H ₁₅ B)	187.4	BC ₃	
B-MWCNT [10]	Triphenylborane (C ₁₈ H ₁₅ B)	186.5	B Cluster	Referring [1]
		187.5	B ₄ C	
		189.5	BC ₃	
		191.0	BC ₂ O	
		192.3	BCO ₂	
		193.0	B ₂ O ₃	
B-MWCNT [11]	Triphenylborane (C ₁₈ H ₁₅ B)	186.6	B Cluster	Referring [1]
		187.6	B ₄ C	
		189.5	BC ₃	
		191.0	BCN	
		191.4	BC ₂ O	
		192.5	BCO ₂	
B-MWCNT [12]	Diborane (B ₂ H ₆)	191.0	B-C	
B-DWCNT [13]	Triisopropyl Borate (C ₉ H ₂₁ BO ₃)	187.9	B ₄ C	Referring [1]
		189.0	BC ₃	
		190.0	BC ₂ O	
		192.0	BCO ₂	
		193.2	B ₂ O ₃	
B-SWCNT [14]	CoNiB Amorphous Alloy	190.1	B-C	
		192.6	B-O	
B-SWCNT [15]	Boron Oxide (B ₂ O ₃)	191.5	BC ₃	Referring [3]
		192.8	B ₂ O ₃	
C ₅₉ B [16]	Boron Nitride (BN), Boron Carbide (B ₄ C), Boron	188.8	BC ₃	
		192.4	H ₃ BO ₃ , B ₂ O ₃	

Table S2. Resistivity of the pristine and boron doped SWCNT sheets measured at 297 K.

I.D.	Resistivity at 297 K ($\Omega\cdot\text{cm}$)				
	Pristine	Boron doping temperature ($^{\circ}\text{C}$)			
		1200	1300	1400	1500
Metallic	3.02×10^{-4}	3.19×10^{-4}	1.07×10^{-3}	1.27×10^{-3}	1.36×10^{-3}
Un-separated	5.60×10^{-3}	3.58×10^{-3}	3.34×10^{-3}	3.11×10^{-3}	3.17×10^{-3}
Semiconducting	2.50×10^{-1}	1.79×10^{-2}	1.03×10^{-2}	8.16×10^{-3}	5.63×10^{-3}

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